

Notice of References Cited		Application/Control No. 10/698,393	Applicant(s)/Patent Under Reexamination ODA ET AL.	
		Examiner Patrick J. Lee	Art Unit 2878	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,777,661 B2	08-2004	Summa et al.	250/208.1
*	B	US-5,610,390	03-1997	Miyano, Hitoshi	250/216
*	C	US-2004/0125226 A1	07-2004	Kubo, Naoki	348/340
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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